

3.091 – Introduction to Solid State Chemistry**Lecture Notes No. 5****X-RAYS AND X-RAY DIFFRACTION**

Sources for Further Reading:

1. Azaroff, L.V., Introduction to Solids, McGraw-Hill, 1960.
2. Wert, C.A., and Thomson, R.M., Physics of Solids, McGraw-Hill, 1970.
3. Nuffield, E.W., X-Ray Diffraction Methods, Wiley, 1966.
4. Cullity, B.D., Elements of X-Ray Diffraction, Addison-Wesley, 1960.

1. HISTORICAL INTRODUCTION

X-rays were discovered during the summer of 1895 by Wilhelm Röntgen at the University of Würzburg (Germany). Röntgen was interested in the *cathode rays* (beams of electrons) developed in discharge tubes, but it is not clear exactly which aspects of cathode rays he intended to study. By chance he noticed that a fluorescent screen (ZnS + Mn⁺⁺) lying on a table some distance from the discharge tube emitted a flash of light each time an electrical discharge was passed through the tube. Realizing that he had come upon something completely new, he devoted his energies to investigating the properties of the unknown ray "X" which produced this effect. The announcement of this discovery appeared in December 1895 as a concise ten page publication.

The announcement of the discovery of X-rays was received with great interest by the public. Röntgen himself prepared the first photographs of the bones in a living hand, and use of the radiation was quickly adopted in medicine. In the succeeding fifteen years, however, very few fundamental insights were gained into the nature of

X-radiation. There was some indication that the rays were waves, but the evidence was not clear-cut and could be interpreted in several ways. Then, at the University of Munich in 1912, Max von Laue performed one of the most significant experiments of modern physics. At his suggestion, Paul Knipping (who had just completed a doctoral thesis with Röntgen) and Walter Friedrich (a newly appointed assistant to Sommerfeld) directed a beam of X-rays at a crystal of copper sulfate and attempted to record the scattered beams on a photographic plate. The first experiment was unsuccessful. The result of a second experiment was successful. They observed the presence of spots produced by diffracted X-ray beams grouped around a larger central spot where the incident X-ray beam struck the film. This experiment demonstrated conclusively that X-radiation consisted of waves and, further, that the crystals were composed of atoms arranged on a *space lattice*.

2. ORIGIN OF X-RAY SPECTRA

The interpretation of X-ray spectra according to the Bohr theory (LN-1) of electronic levels was first (and correctly) proposed by W. Kossel in 1920: the electrons in an atom are arranged in shells (K, L, M, N, corresponding to $n = 1, 2, 3, 4, \dots$, etc.). Theory predicts that the energy differences between successive shells increase with decreasing n and that the electron transition from $n = 2$ to $n = 1$ results in the emission of very energetic (short wavelength) radiation (fig. 1), while outer shell transitions (say,

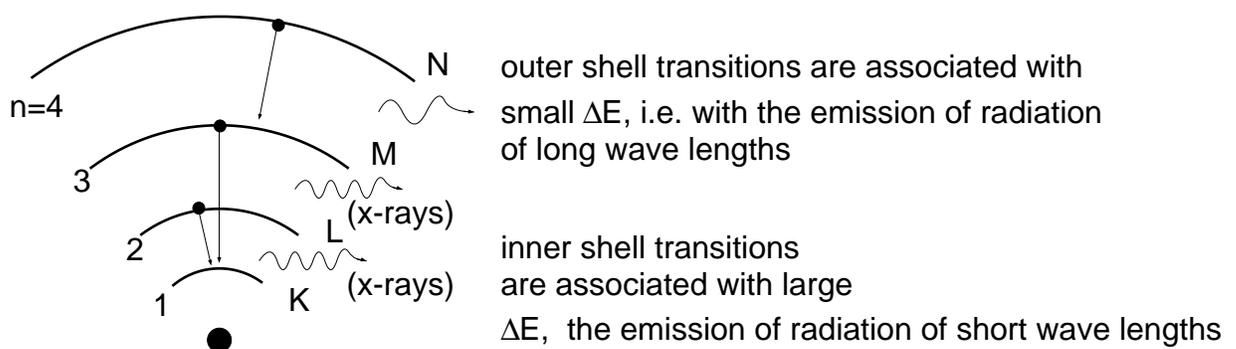


Figure 1 X-rays are generated by inner shell electron transitions

from $n = 5$ to $n = 4$) yield low energy radiation (long wavelength). For hydrogen, you recall, the wave number of the emitted radiation associated with a particular electron transition is given by the Rydberg equation:

$$\bar{\nu} = \left(\frac{1}{n_i^2} - \frac{1}{n_f^2} \right) R$$

For “hydrogen-like” atoms with the atomic number Z (containing one electron only) the corresponding Rydberg equation becomes:

$$\bar{\nu} = \left(\frac{1}{n_i^2} - \frac{1}{n_f^2} \right) RZ^2$$

From this relationship it is apparent that the energy difference associated with electron transitions increases strongly with the atomic number and that the wavelength of radiation emitted during such transitions moves with increasing Z from the 10^{-7} m range to the 10^{-10} m range (radiation now defined as X-rays).

To bring about such inner shell transitions requires the generation of an *electron vacancy*: an electron must be removed, for example from the K shell ($n = 1$), of an atom. Such a vacancy is conveniently produced in an X-ray tube by an electron beam (generated by a heated filament which is made a cathode) impinging, after being subjected to an accelerating potential of several kV, into a target material made anode (fig. 2). The impinging electrons will transfer part of their energy to electrons of the

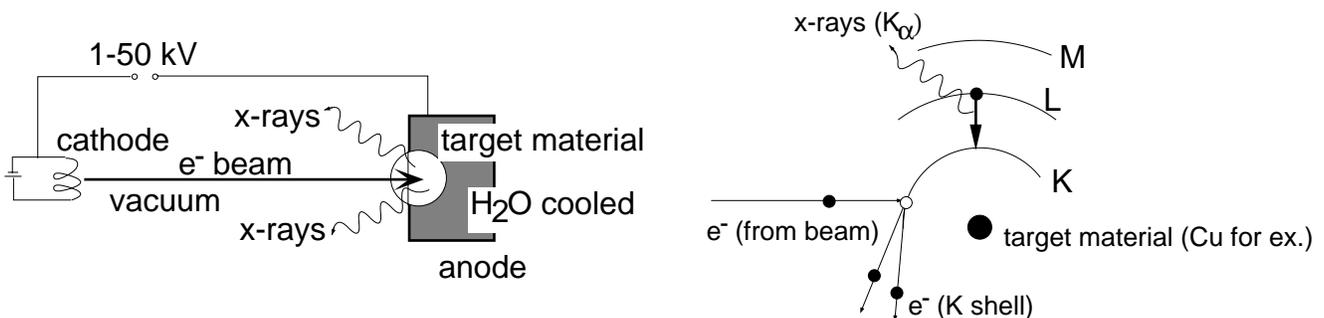


Figure 2 Generation of x-rays

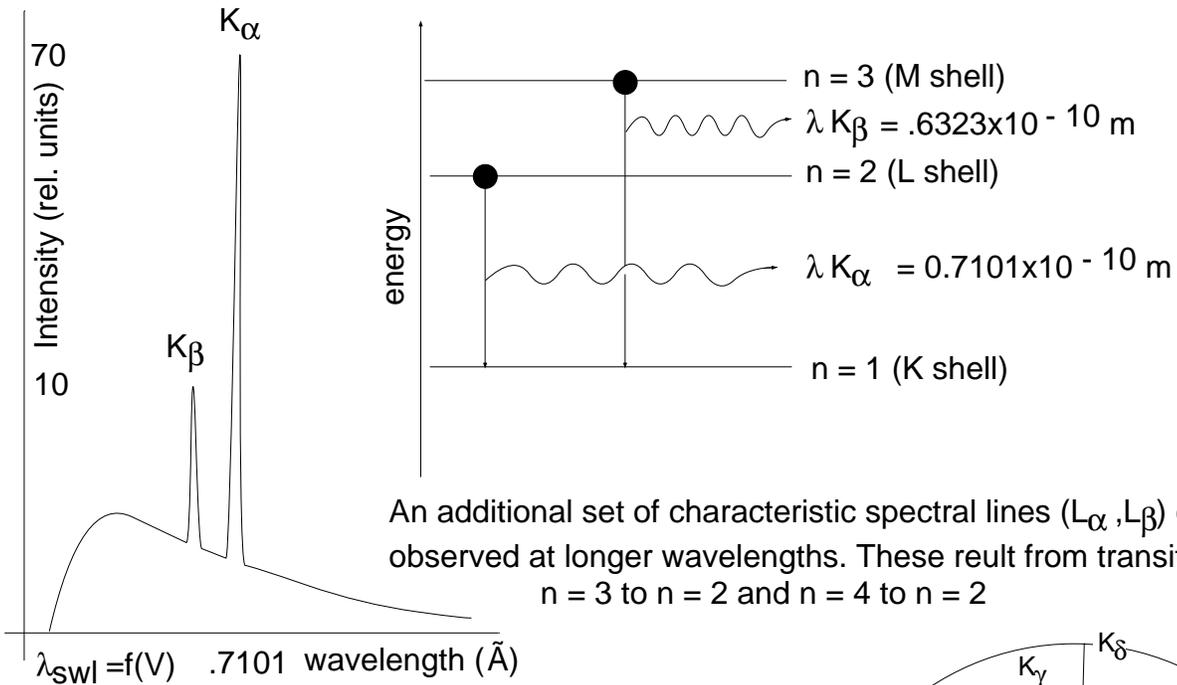
target material and result in electronic excitation. If the energy of the arriving electrons is high enough, some may knock out a K shell electron in the target and thus generate a vacancy. [It should be clear that a $K \rightarrow L$ excitation cannot take place since the L shell is filled: excitation must involve $(n = 1) \rightarrow (n = \infty)$.] When such a vacancy is generated, it can readily be filled by an electron from the L shell or the M shell of the same atom. These internal electron transitions give rise to the emission of “characteristic” X-radiation which, because of its short wavelength, has extremely high “penetrating” power. [Since an electron beam is used to generate X-rays, the *X-ray tube* has to be evacuated: to dissipate the energy flux arriving at the target, the anode support (onto which the target is mounted) is water-cooled.]

Under standard operating conditions, the *characteristic radiation* emitted by the target comprises two sharp lines, referred to as K_α and K_β lines (fig. 3). They are associated, respectively, with electron transitions from $n = 2$ to $n = 1$ and from $n = 3$ to $n = 1$.

Emitted X-ray spectra were extensively studied by H.G.J. Moseley who established the relationship between the wavelength of characteristic radiation and the atomic number Z of the radiation emitting target material (fig. 4). Experimentally he found that the K_α lines for various target materials (elements) exhibit the relationship:

$$\lambda K_\alpha \propto \frac{1}{Z^2} \quad (\bar{\nu} K_\alpha \propto Z^2)$$

Moseley’s empirical relationship (which reflects a behavior in agreement with the Rydberg equation) can be quantified. While the energy levels associated with outer electron transitions are significantly affected by the “screening” effect of inner electrons (which is variable and cannot as yet be determined from first principles), the conditions associated with X-ray generation are simple. Very generally, the screening effect of the innermost electrons on the nuclear charge is accounted for in an effective nuclear



Spectrum of molybdenum (Mo) at 35 kV (schematic).

Electronic transitions that give rise to characteristic lines of X - ray spectra. The subscripts α, β, γ and δ designate the change in principle quantum number and are not related to intensity

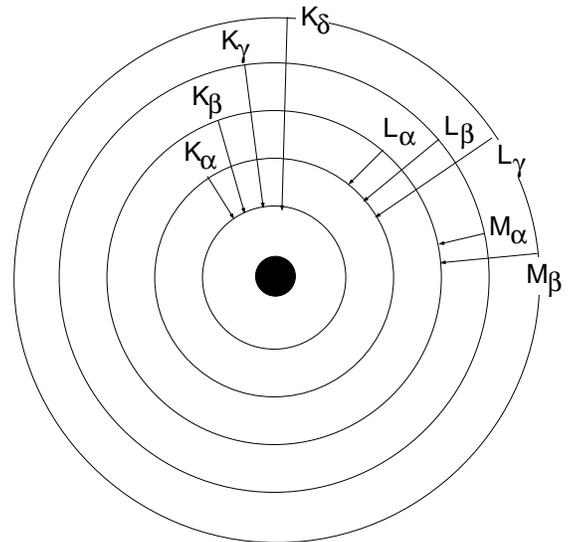


Figure 3 Electronic transitions giving rise to characteristic X- ray spectra.

charge ($Z - \sigma$) and the Rydberg equation assumes the form:

$$\bar{\nu} = \left(\frac{1}{n_i^2} - \frac{1}{n_f^2} \right) R (Z - \sigma)^2$$

where σ = screening effect

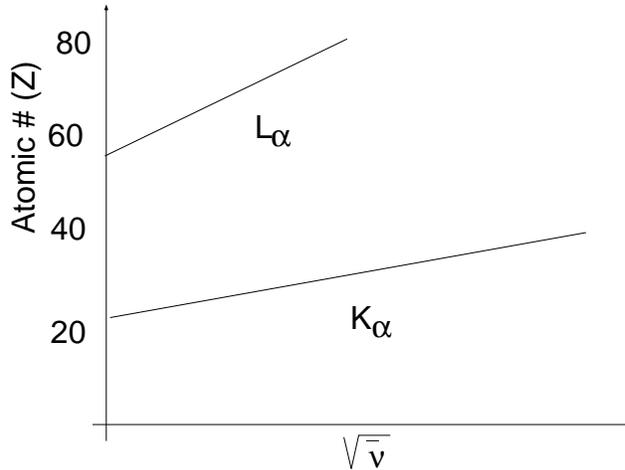


Figure 4 Moseley relationship for K_{α} and L_{α} radiation

Considering the transition $n_2 \rightarrow n_1$, screening of the full nuclear charge is only provided by the one electron remaining in the K shell. Thus it is possible to use the modified Rydberg equation, taking $\sigma = 1$. Accordingly, we have:

$$\bar{\nu}K_{\alpha} = \left(\frac{1}{2^2} - \frac{1}{1^2} \right) R (Z - 1)^2 = - \frac{3}{4} R (Z - 1)^2$$

where: R = Rydberg constant and Z = atomic number of the target material. [The minus sign (-) only reflects radiative energy given off by the system.]

Similarly, for the characteristic L_{α} series of spectral lines ($n = 3$ to $n = 2$) we find, after removal of one L electron, that the screening of the electrons in the K shell and the remaining electrons in the L shell reduces the nuclear charge by 7.4 (empirical value).

$$\bar{\nu}L_{\alpha} = \left(\frac{1}{3^2} - \frac{1}{2^2} \right) R (Z - 7.4)^2 = - \frac{5}{36} R (Z - 7.4)^2$$

A second look at the X-ray spectrum of a Mo target, obtained with an electron accelerating potential of 35 kV (fig. 5), shows that the characteristic radiation (K_{α} , K_{β}) appears superimposed on a continuous spectrum (continuously varying λ) of lower and varying intensity. This continuous spectrum is referred to as *bremstrahlung* (*braking radiation*) and has the following origin. Electrons, impinging on the target material, may lose their energy by transferring it to orbiting electrons, as discussed above; in many instances, however, the electrons may come into the proximity of the force fields of *target nuclei* and, in doing so, will be “slowed down” or decelerated to a varying degree,

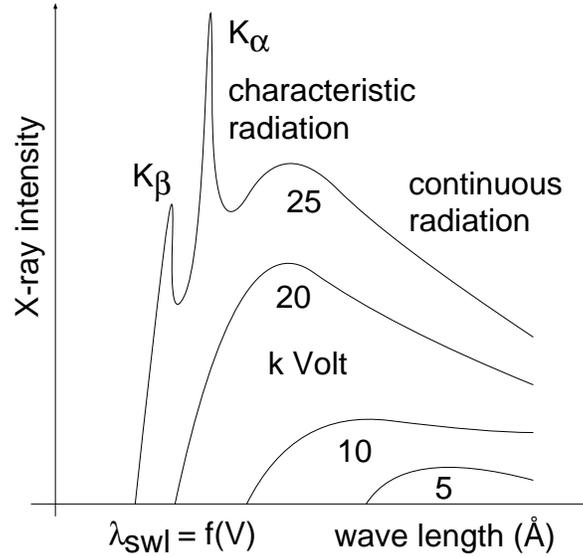
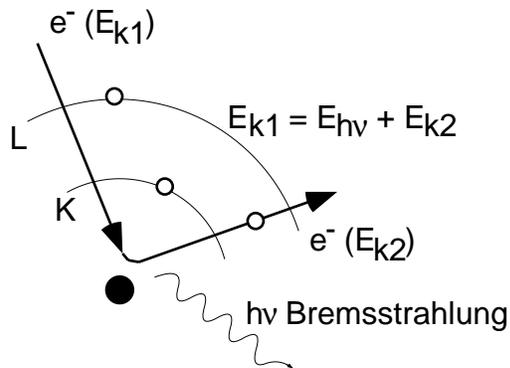


Figure 5 X-ray spectrum of Mo target as a function of applied Voltage.

ranging from imperceptible deceleration to total arrest. The energy lost in this slowing down process is emitted in the form of radiation (braking radiation, or bremsstrahlung). This energy conversion, as indicated, can range from partial to complete (fig. 6). The



for $E_{k2} = 0$, $E_{(h\nu)\max} = E_{k1} = \lambda_{SWL} = h\nu = eV$; $\lambda_{SWL} = hc/eV$
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Figure 6 Origin of Bremsstrahlung; the continuous part of the X-ray spectrum

incident electrons have an energy of $e \cdot V$ (electronic charge times accelerating Voltage) in the form of kinetic energy ($mv^2/2$), and their total energy conversion gives rise to a

Shortest Wavelength (SWL) – the cut-off of the continuous spectrum for decreasing values of λ (fig. 5). Analytically, we have:

$$eV = h\nu_{\max} = h \frac{c}{\lambda_{\text{SWL}}} \quad ; \quad \lambda_{\text{SWL}} = \frac{hc}{eV}$$

From this relationship it is evident that the cut-off of the continuous spectrum toward decreasing λ 's (λ_{SWL}) is controlled by the accelerating potential (fig. 5).

3. THE “FINE STRUCTURE” OF CHARACTERISTIC X-RAYS

It is customary to consider the characteristic X-ray spectral lines as discrete lines (K_{α} , K_{β} , L_{α} , L_{β} , etc.). In reality, they are not discrete since the electron shells involved in the associated electron transitions have energy *sublevels* (s, p, d orbitals). These sublevels give rise to a “fine structure” insofar as the K_{α} lines are doublets composed of $K_{\alpha 1}$ and $K_{\alpha 2}$ lines. Similarly, L_{α} , L_{β} , etc., exhibit a fine structure.

These considerations suggest that X-ray spectra contain information concerning the energetics of electronic states. Obviously, analysis of X-rays emitted from a target of unknown composition can be used for a quantitative chemical analysis. [This approach is taken routinely in advanced scanning electron microscopy (SEM) where X-rays, generated by the focused electron-beam, are analyzed in an appropriate spectrometer.]

In fundamental studies it is also of interest to analyze soft (long λ) X-ray spectra. For example, take the generation of X-rays in sodium (Na). By generating an electron vacancy in the K shell, a series of K_{α} and K_{β} lines will result. The cascading electron generates vacancies in the 2p level, which in turn can be filled by electrons entering from the 3s level (generation of “soft” X-rays). If the X-rays are generated in a Na vapor, the 3s \rightarrow 2p transition will yield a sharp line; on the other hand, if X-rays are analyzed in sodium metal, the same transition results in the emission of a continuous broad band, about 30 Å in width. This finding confirms the existence of an *energy band* (discussed earlier).

An analysis of the width and intensity distribution of the X-ray band provides experimental data concerning the energy band width and the energy state density distribution within the energy band (fig. 7).

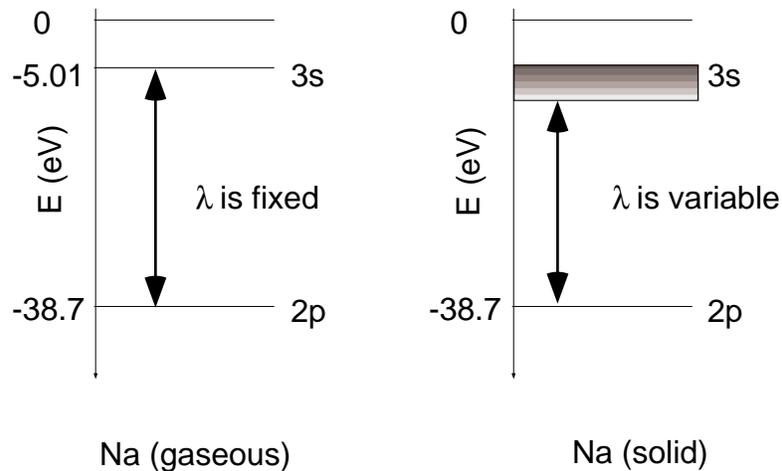


Figure 7 Soft X-rays from 3s - 2p transitions in solid Na and Na vapor

4. USE OF X-RAYS FOR STRUCTURAL ANALYSIS

The extensive use of X-rays for the analysis of atomic structural arrangements is based on the fact that waves undergo a phenomenon called *diffraction* when interacting with systems (diffracting centers) which are spaced at distances of the same order of magnitude as the wavelength of the particular radiation considered. X-ray diffraction in crystalline solids takes place because the atomic spacings are in the 10^{-10} m range, as are the wavelengths of X-rays.

5. DIFFRACTION AND BRAGG'S LAW

The atomic structure of crystalline solids is commonly determined using one of several different X-ray diffraction techniques. Complementary structure information can also be obtained through electron and neutron diffraction. In all instances, the radiation used must have wavelengths in the range of 0.1 to 10 Å because the resolution (or smallest object separation distance) to which any radiation can yield useful information is about

equal to the wavelength of the radiation, and the average distance between adjacent atoms in solids is about 10^{-10}m (1 \AA). Since there is no convenient way to focus X-rays with lenses and to magnify images, we do not attempt to look directly at atoms. Rather, we consider the interference effects of X-rays when scattered by the atoms, comprising a crystal lattice. This is analogous to studying the structure of an optical diffraction grating by examining the interference pattern produced when we shine visible light on the grating. (The spacing of lines on a grating is about 0.5 to $1 \mu\text{m}$ and the wavelength of visible radiation ranges from 0.4 to $0.8 \mu\text{m}$.) In the optical grating the ruled lines act as scattering centers, whereas in a crystal it is the atoms (more correctly, the electrons about the atom) which scatter the incident radiation.

The geometrical conditions which must be satisfied for diffraction to occur in a crystal were first established by Bragg. He considered a monochromatic (single wavelength) beam of X-rays with coherent radiation (X-rays of common wave front) to be incident on a crystal, as shown in fig. 8. Moreover, he established that the atoms which

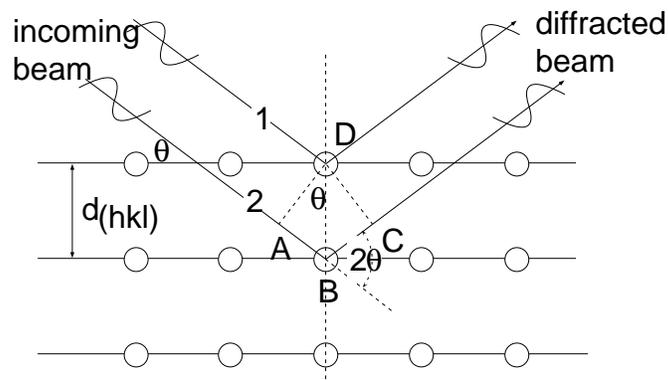


Figure 8 Bragg's law, assuming the planes of atoms behave as reflecting planes.

constitute the actual scattering centers can be represented by sets of parallel planes (in which the atoms are located) which act as mirrors and "reflect" the X-rays. In cubic systems the spacing of these planes, $d_{(hkl)}$ (see LN-4), is related to the lattice constant

(a):

$$d_{(hkl)} = \frac{a}{\sqrt{h^2 + k^2 + l^2}} \quad (1)$$

For constructive interference of the scattered X-rays (the appearance of a diffraction peak) it is required that the beams, scattered on successive planes, be “in phase” (have again a common wave front) after they leave the surface of the crystal. In terms of the beams labeled 1 and 2 in fig. 8 this requires that the distance $\overline{AB} + \overline{BC}$ be equal to an integral number of wavelengths (λ) of the incident radiation. Accordingly:

$$\overline{AB} + \overline{BC} = n\lambda \quad (n = 1, 2, 3, \dots)$$

Since $\overline{AB} = \overline{BC}$ and $\sin \theta = \frac{\overline{AB}}{d_{(hkl)}}$ [$\overline{AB} = d_{(hkl)} \sin \theta$]:

$$n\lambda = 2d_{(hkl)} \sin \theta \quad (2)$$

This relation is referred to as *Bragg's Law* and describes the angular position of the diffracted beam in terms of λ and $d_{(hkl)}$. In most instances of interest we deal with first order diffraction ($n = 1$) and, accordingly, Bragg's law is:

$$\lambda = 2d_{(hkl)} \sin \theta$$

[We are able to make $n = 1$ because we can always interpret a diffraction peak for $n = 2, 3, \dots$ as diffraction from $(nh \ nk \ nl)$ planes – i.e., from planes with one-nth the interplanar spacing of $d_{(hkl)}$.]

If we consider fig. 8 as representative for a “diffractometer” set-up (fig. 11), we have a collimated beam of X-rays impinging on a (100) set of planes and at 2θ to the incident beam a detector which registers the intensity of radiation. For a glancing incident beam (small θ) the detector will register only background radiation. As θ increases to a value for which $2d \sin \theta = \lambda$, the detector will register high intensity radiation – we have a

diffraction peak. From the above it is evident that the diffraction angle (θ) increases as the interplanar spacing, $d_{(hkl)}$, decreases.

The diffraction experiment as presently considered is intended to provide quantitative information on the volume (the lattice constant a) and shape characteristics (SC, BCC, FCC) of the unit cell. The intensity of diffraction peaks depends on the phase relationships between the radiation scattered by all the atoms in the unit cell. As a result, it happens quite often that the intensity of a particular peak, whose presence is predicted by Bragg's law, is zero. (This is because Bragg's law deals not with atom positions, but only with the size and shape of the unit cell.) For example, consider the intensity of the (100) diffraction peak of a crystal which has a BCC unit cell. The phase relationships show that the X-rays scattered at the top and bottom faces of the unit cell, (100) planes, interfere constructively, but are 180° out of phase with the X-rays scattered by the atom at the center of the unit cell. The resultant intensity is therefore zero. The rules which govern the presence of particular diffraction peaks in the different cubic Bravais lattices (SC, BCC and FCC) are given in Table I.

TABLE I. *Selection Rules for Diffraction Peaks in Cubic Systems*

<u>Bravais Lattice</u>	<u>Reflections Present</u>	<u>Reflections Absent</u>
Simple Cubic	All	None
Body-Centered Cubic	$(h+k+l) = \text{even}$	$(h+k+l) = \text{odd}$
Face-Centered Cubic	h, k, l unmixed (either all odd or all even)	h, k, l mixed

The rules given are strictly true only for unit cells where a single atom is associated with each lattice point. (Unit cells with more than one atom per lattice point may have their atoms arranged in positions such that reflections cancel. For example, diamond has an FCC Bravais lattice with two atoms per lattice point. All reflections present in diamond have unmixed indices, but reflections such as $\{200\}$, $\{222\}$ and $\{420\}$ are missing. The

fact that all reflections present have unmixed indices indicates that the Bravais lattice is FCC – the extra missing reflections give additional information as to the exact atom arrangement.)

A hypothetical diffraction experiment: A material is known to be of simple cubic structure; determine a , the lattice constant, by X-ray diffraction. In theory, the question may be answered by placing the crystal into a diffractometer, rotating it into all possible positions relative to the incident X-ray beam and recording all diffracting 2θ values. From the above we know that the smallest observed θ value must correspond to diffraction on $\{100\}$ planes and also that $d_{(100)} = a$. We may now use Bragg's equation to determine a , the lattice constant:

$$\lambda = 2d \sin \theta = 2a \sin \theta$$

$$a = \frac{\lambda}{2 \sin \theta}$$

There are two simplifying assumptions in this problem: (1) we know the system is SC and (2) we are able, through rotation, to bring all planes present into diffraction conditions.

6. EXPERIMENTAL APPROACHES TO X-RAY DIFFRACTION

In the context of this course we are interested in making use of X-ray diffraction for the purpose of (a) identifying (cubic) crystal systems, (b) determining the lattice constant, a , and (c) identifying particular planes or meaningful orientations. The possible approaches can, in principle, be identified through an examination of Bragg's law. The Bragg condition for particular $d_{(hkl)}$ values can be satisfied by adjusting either one of two experimental variables: (a) λ , the wavelength of the X-ray beam used, or (b) θ , the orientation of the crystal planes relative to the incident X-rays.

(a) Fixed θ , Variable λ : One means of satisfying Bragg's law is to irradiate a stationary single crystal (θ fixed for all planes within the crystal) with an X-ray beam of "white" radiation, which contains the characteristic and continuous spectrum produced by an X-ray tube. (For λ variable we have the simultaneous exposure of a crystal to a range of λ values). Each set of planes will reflect (diffract) the particular λ which satisfies the Bragg condition for the fixed θ . The diffracted beams may conveniently be recorded with a Polaroid camera or, alternately, with an electronic imaging device. It is possible to analyze either the transmitted or the back-reflected X-rays. This experimental procedure is referred to as the *Laue technique* (fig. 9); it is mostly conducted in the

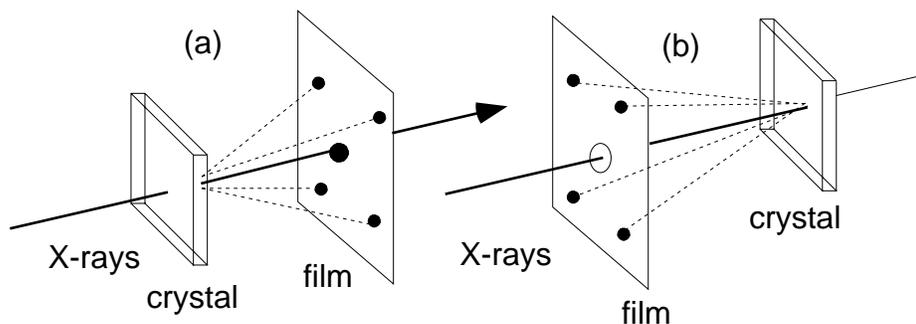


Figure 9 Laue diffraction in (a) transmission and (b) back-reflection mode

back-reflection mode. Note that the approach taken makes it possible to determine the values of θ for each reflection, but not the corresponding λ . Therefore, the technique cannot be used, for example, to determine lattice constants. However, it is very valuable if particular planes or crystal orientations are to be identified.

(b) Fixed λ (Monochromatic X-Rays), Variable θ : The basic prerequisite for this approach is the availability of a monochromatic X-radiation of known wavelength (λ). Such radiation can be conveniently obtained by using a crystal (i.e., its diffracting property) as a filter or monochromator (fig. 10). Filter action is achieved by positioning the crystal in such a way that the unfiltered radiation emitted by the X-ray tube becomes incident at an angle, θ , on a set of low index planes which satisfy Bragg's law

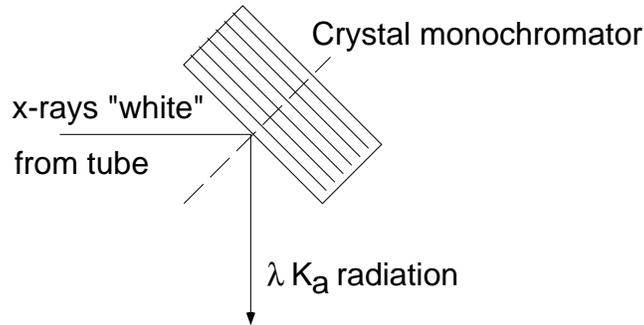


Figure 10 Isolation of monochromatic radiation from target radiation

for the highest intensity radiation (K_{α}) emitted. The condition of a fixed λ and variable θ is experimentally used in two techniques. Using a *diffractometer* (fig. 11), we place a

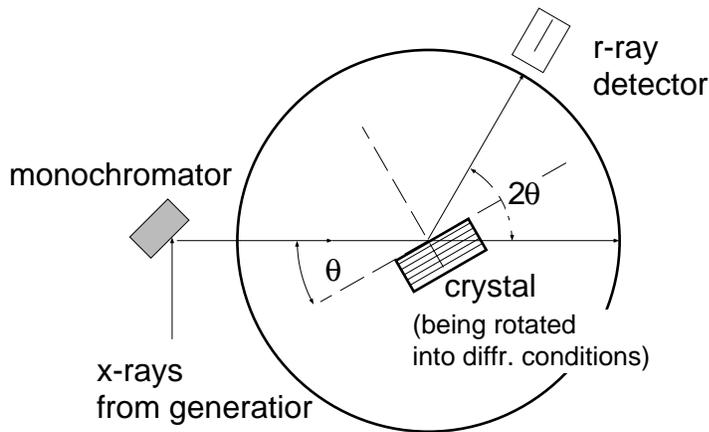


Figure 11 X-ray Diffractometer setup.

sample (ground to a powder) into the center of a rotating stage and expose it to a monochromatic X-ray beam. The sample is rotated into diffraction condition and the diffraction angle determined. In the Debye-Scherrer method (fig.12) the sample

is ground to a powder and placed (in an ampoule) into the center of a Debye-Scherrer camera. Exposed to monochromatic X-rays, in this way a large number of diffracted cone-shaped beams are generated such that the semiangles of the cones measure 2θ , or twice the Bragg angle for the particular diffracting crystallographic planes. The reason diffracted beams are cone-shaped is that the planes in question (within the multitude of randomly oriented grains) give rise to diffraction for any orientation around the incident beam as long as the incident beam forms the appropriate Bragg angle with these planes – thus there is a rotational symmetry of the diffracted beams about the

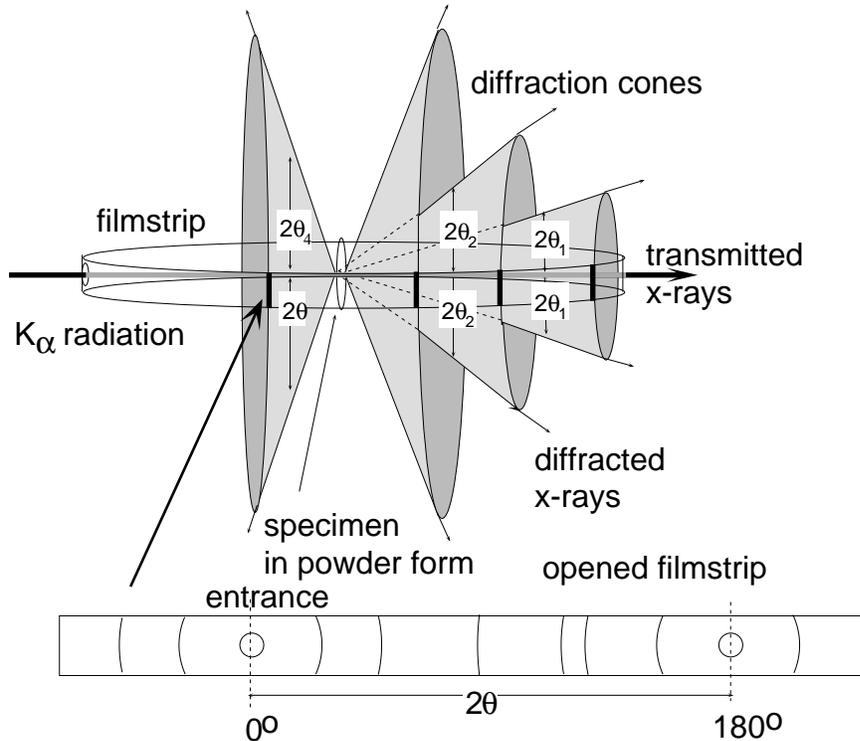


Figure 12 Debye-Scherrer powder diffraction setup and analysis

direction of the incident beam. Those planes with the largest interplanar spacing have the smallest Bragg angle, θ .

In a Debye–Scherrer arrangement, after exposing a powder of a crystalline material to monochromatic X-rays, the developed film strip will exhibit diffraction patterns such as indicated in fig. 12. Each diffraction peak (dark line) on the film strip corresponds to constructive interference at planes of a particular interplanar spacing [$d_{(hkl)}$]. The problem now consists of “indexing” the individual lines – i.e., determining the Miller indices (hkl) for the diffraction lines:

$$\begin{aligned} \text{Bragg: } \quad \lambda &= 2d_{(hkl)} \sin \theta & ; & \quad d_{(hkl)} = \frac{a}{\sqrt{h^2 + k^2 + l^2}} \\ \lambda^2 &= 4d_{(hkl)}^2 \sin^2 \theta & ; & \quad d_{(hkl)}^2 = \frac{a^2}{(h^2 + k^2 + l^2)} \end{aligned}$$

Substitution and rearrangement of above yields:

$$\frac{\sin^2 \theta}{(h^2 + k^2 + l^2)} = \frac{\lambda^2}{4a^2} = \text{const.}$$

Accordingly, we find that for all lines (θ values) of a given pattern, the relationship

$$\frac{\sin^2 \theta_1}{(h^2 + k^2 + l^2)_1} = \frac{\sin^2 \theta_2}{(h^2 + k^2 + l^2)_2} = \frac{\sin^2 \theta_3}{(h^2 + k^2 + l^2)_3} = \text{const.}$$

holds. Since the sum $(h^2 + k^2 + l^2)$ is always integral and $\lambda^2/4a^2$ is a constant, the problem of indexing the pattern of a cubic system is one of finding a set of integers $(h^2 + k^2 + l^2)$ which will yield a constant quotient when divided one by one into the observed $\sin^2\theta$ values. (Certain integers such as 7, 15, 23, etc. are impossible because they cannot be formed by the sum of three squared integers.)

Indexing in step-by-step sequence is thus performed as follows: θ values of the lines are obtained from the geometric relationship of the unrolled film strip. Between the exit hole of the X-ray beam ($2\theta = 0^\circ$) and the entrance hole ($2\theta = 180^\circ$) the angular relationship is linear (fig. 12). The increasing θ values for successive lines are indexed $\theta_1, \theta_2, \theta_3$, etc., and $\sin^2\theta$ is determined for each. If the system is simple cubic we know that all planes present will lead to diffraction and the successive lines (increasing θ) result from diffraction on planes with decreasing interplanar spacing: (100), (110), (111), (200), (210), (211), (220), etc. From equation (3) above we recognize:

$$\frac{\sin^2 \theta_1}{1} = \frac{\sin^2 \theta_2}{2} = \frac{\sin^2 \theta_3}{3} = \frac{\sin^2 \theta_4}{4} = \frac{\sin^2 \theta_5}{5} = \text{const.}$$

If the system is BCC, however, we know from the selection rules that only planes for which $(h + k + l) = \text{even}$ will reflect. Thus:

$$\frac{\sin^2 \theta_1}{2} = \frac{\sin^2 \theta_2}{4} = \frac{\sin^2 \theta_3}{6} = \frac{\sin^2 \theta_4}{8} \text{ etc.} = \text{const.}$$

[SC can be differentiated from BCC through the fact that no sum of three squared integers can yield 7, but 14 can be obtained from planes (321)].

For FCC systems, the selection rules indicate reflections on planes with unmixed h,k,l indices:

$$\frac{\sin^2 \theta_1}{3} = \frac{\sin^2 \theta_2}{4} = \frac{\sin^2 \theta_3}{8} = \text{const.}$$

After proper indexing, the constant is obtained:

$$\frac{\sin^2 \theta}{(h^2 + k^2 + l^2)} = \text{const.}$$

and the particular Bravais lattice is identified. The lattice constant of the unit cell is subsequently obtained, knowing the wavelength of the incident radiation:

$$\frac{\sin^2 \theta}{(h^2 + k^2 + l^2)} = \text{const.} = \frac{\lambda^2}{4a^2}$$

$$a^2 = \frac{\lambda^2}{4 \sin^2 \theta} (h^2 + k^2 + l^2)$$

$$a = \frac{\lambda}{2 \sin \theta} \sqrt{(h^2 + k^2 + l^2)}$$

EXERCISE FOR THE IDLE MIND

1. (a) Give a schematic drawing of the X-ray spectrum emitted from a molybdenum (Mo) target and identify on it with appropriate symbols all characteristic wavelengths.
 (b) Explain the origin of all characteristic “ λ 's” on a schematic drawing and an energy diagram respectively.
 (c) Assuming the X-ray unit is operated with an accelerating voltage of 40 kV, what is the shortest X-ray wavelength (λ) obtained from it?

2. A powder of a material, crystallizing in a BCC structure ($a = 10 \times 10^{-10}$ m), is exposed to the radiation emitted from an X-ray tube operated at a voltage (V). Below which value of V will no wavelength emitted by the X-ray tube be able to cause diffraction?

3. For an unknown cubic metal the diffracting angles, θ , obtained with CuK_{α} radiation ($\lambda = 1.541 \text{ \AA}$) are: 20.1° , 29.2° , 36.6° , 43.5° , 50.2° , 57.4° , 65.5° .
 (a) Determine the lattice constant “a” for this metal.
 (b) Determine the atomic radius for this metal.

4. Calculate the angular position of the first diffraction peak (smallest θ) for Cr and for Pd using CuK_{α} radiation ($\lambda = 1.542 \text{ \AA}$).

5. Gold (Au) is studied in a Debye-Scherrer diffraction arrangement. Using radiation of 1 \AA , what is the diffraction angle (θ) for (a) the (112) planes and (b) the (220) planes?

6. An X-ray generator operates with a deficient power supply which can only deliver an accelerating voltage of kV.
 (a) Will you be able to obtain CuK_{α} radiation ($\lambda = 1.542 \text{ \AA}$) from this generator?
 (b) What is the shortest λ of X-radiation obtainable?
 (c) Assuming the shortest λ obtainable through Bremsstrahlung (λ_{SWL}) were 1.380 \AA , which is the same wavelength as that of CuK_{β} , could CuK_{α} radiation be obtained under these conditions?

7. From a hypothetical diffraction experiment involving a “cubic” crystal, the following $\sin^2\theta$ values are obtained: 0.100, 0.200, 0.300, 0.400, 0.500, 0.600, 0.800 and 0.900. Is this system SC, BCC or FCC? Attempt to find the answer by deductive reasoning along; after writing down the answer, explain how you arrived at your conclusion.

8. An element of BCC structure crystallizes with a lattice constant (a) of 3.26 Å. What is the minimum acceleration potential that must be applied to an X-ray generator so as to still observe in this material X-ray diffraction with radiation emanating from this tube?
9. What will be the Miller indices for the smallest diffracting angles (with a given fixed λ) for:
 - (a) SC crystals?
 - (b) FCC crystals?
 - (c) BCC crystals?
10. On a crystal (cubic) a set of diffraction lines (θ) was obtained with CuK_α (1.54 Å) radiation: 13.70, 15.89, 22.75, 26.91, 28.25, 33.15, 36.62, 37.60 and 41.95 degrees. What is the lattice parameter of this solid?
11. Using CuK_α radiation in a diffraction experiment on Ag, what are the values of the three smallest θ angles?
12. What is the smallest acceleration potential that must be applied to an X-ray generator so as to still achieve diffraction in solid potassium (at room temperature)?
13. For a diffraction experiment on gold (Au) a collimated beam of electrons, rather than X-rays, is used. Assuming the acceleration potential (V) for the electron is 45 kV, what will be the Bragg angle, θ , for (220) diffraction?
14. Using K_α radiation of vanadium (V) in a diffraction experiment on an unknown cubic (BCC) material, the first diffraction peak is observed at $2\theta = 83.5^\circ$. What is the lattice constant (a) of this material?
15. The interplanar spacing of the {110} planes in an iron (Fe) crystal is 2.024 Å. At that Bragg angle (θ) will AgK_α radiation experience first order diffraction (also called reflection) on these planes?
16. An X-ray generator with an unknown target material yields K_α radiation with which the smallest diffraction peak ($2\theta_1$) in tantalum (Ta) is found to be at 58.7° . What is the target material in the X-ray generator?
17. On a Debye-Scherrer film strip, after exposure to diffraction from a face-centered cubic Ni specimen, the separation between the two lines lying closest to the position of the undiffracted (transmitted) beam is 7.8 cm.
 - (a) What planes of the crystal structure are responsible for these lines?
 - (b) Knowing that the radius of the camera is 5 cm and that CuK_α radiation is used in this experiment, determine the atomic radius of Ni.

18. Using electrons accelerated by 100,000 Volt, what will be θ (the diffraction angle) for diffraction on (112) planes in gold (Au)?
19. The Debye-Scherrer pattern of an unknown material exhibits reflections (diffraction peaks) at 40.50° , 58.60° , 73.64° , 87.62° , 101.38° , 116° and 132.6° , using $\text{CuK}\alpha$ radiation ($\lambda = 1.541 \text{ \AA}$). Determine the molar volume of this material.
20. Diffraction experiments on Ag are made at 300K and at 1073K with $\text{MoK}\alpha$ radiation ($\lambda = 0.709 \text{ \AA}$). It is found that the diffraction angle $\theta_{(111)}$ at 1073K is by 0.11° smaller than that at 300K. Determine the molar volume of Ag at 800°C . (You may make use of information in your Periodic Table.)
21. In an unknown material of cubic structure, (100) diffraction is obtained at 14.88° with radiation of $\lambda = 1.541 \text{ \AA}$. Can this material accommodate interstitially (in void space) atoms of 1.08 \AA radius without lattice distortion?
22. A powder of a metallic system with BCC structure and a lattice constant of 5.5 \AA is exposed to the radiation from an X-ray tube operated at 1.2 kV. How many diffraction cones can be generated by this powder in a Debye-Scherrer set-up.
23. You are given an unknown material of irregular shape and are asked to determine (a) if the material is crystalline, (b) if it belongs to the BCC system, and (c) the lattice constant of its unit cell. How would you proceed? (Give your answer in no more than ten lines with no more than three equations.)
24. A powder of an FCC system with a lattice constant (a) of 6 \AA is exposed to radiation emitted from an X-ray tube operated at an accelerating potential (V) of 1.5 kV (the target material is Cr). How many diffraction cones can the radiation emitted generate in a Debye-Scherrer set-up?
25. Do you expect the first diffraction peak in Pd to be shifted to a larger or smaller θ value (operating with $\text{K}\alpha$, monochromatic X-rays) if you change the target in an X-ray tube from Cu to Mo? Explain.
26. Determine the longest wavelength of X-rays which can still produce diffraction in vanadium (V).
27. Determine the wavelength of $\lambda\text{K}\alpha$ for Mo.
28. Identify the element giving rise to $\text{K}\alpha$ with $\lambda = 2.51 \times 10^{-10} \text{ m}$.
29. Determine the longest wavelength of radiation that is still capable of producing diffraction in nickel (Ni).

30. You are operating an X-ray tube with an Mo target by applying an acceleration potential of 50 keV. Draw a schematic of the X-ray spectrum emitted by this tube; label on it three (3) characteristic wavelengths (λ 's) and give the calculated numerical value for two of these.
31. When doing "electron diffraction", what acceleration potential must be applied to a beam of electrons to achieve with them diffraction on {111} planes of gold at $\theta=6^\circ$?
32. Determine the smallest acceleration potential that must be applied in an X-ray generator so as to still achieve diffraction in nickel (Ni).
33. An element, solid, of BCC structure has the lattice constant 0.316 nm with a density of 19.3 g/cm³. Calculate the atomic weight of this element.
34. Draw the schematic of a set-up for an X-ray diffractometer experiment on iron using NiK_α radiation. (Provide as much information as required to achieve monochromatic K_α radiation suitable for the diffraction study.)
35. Determine the chemical element that will generate K_α radiation with an energy of 7.725×10^8 J/mole photons.
36. At what Bragg angle (θ) will K_α radiation from a Ni target experience first order diffraction on {110} planes of BCC iron?
37. Give a definition for the "unit cell".
38. What is the coordination number of each atom in (a) a three-dimensional, close-packed array of equal sized spheres, (b) a simple cubic structure and (c) a body centered cubic lattice?
39. Describe what is understood by "constructive interference" and "destructive interference" and explain how these terms apply to the diffraction of X-rays by a crystal.
40. Explain the fact that a polycrystalline (fine grained) aluminum sample exhibits a higher tensile strength (strength under tension) than a high quality Al single crystal.